



## Accredited Laboratory

A2LA has accredited

**P.K. CALIBRATION & CONSULTING LABS LTD**  
**d.b.a. PK LABS CALIBRATION & CONSULTING**  
*Tefen Industrial Zone city, ISRAEL*

for technical competence in the field of

### Calibration

This laboratory is accredited in accordance with the recognized International Standard ISO/IEC 17025:2017 *General requirements for the competence of testing and calibration laboratories*. This laboratory also meets R205 – Specific Requirements: Calibration Laboratory Accreditation Program. This accreditation demonstrates technical competence for a defined scope and the operation of a laboratory quality management system (refer to joint ISO-ILAC-IAF Communiqué dated April 2017).



Presented this 1<sup>ST</sup> day of November 2021.

A blue ink signature of the Vice President of Accreditation Services.

Vice President, Accreditation Services  
For the Accreditation Council  
Certificate Number 2806.01  
Valid to July 31, 2023

*For the calibrations to which this accreditation applies, please refer to the laboratory's Calibration Scope of Accreditation.*



SCOPE OF ACCREDITATION TO ISO/IEC 17025:2017

P.K. CALIBRATION & CONSULTING LABS LTD  
d.b.a. PK LABS CALIBRATION & CONSULTING  
3 Hadolev Str.  
Tefen Industrial Zone, 24959  
ISRAEL  
Peter Kornhauser Phone: 972 4 9873345

CALIBRATION

Valid To: July 31, 2023

Certificate Number: 2806.01

In recognition of the successful completion of the A2LA evaluation process, accreditation is granted to this laboratory to perform the following calibrations<sup>1, 18</sup>:

I. Chemical Quantities

Parameter/Equipment	Range	CMC <sup>2,4</sup> (±)	Comments <sup>11</sup>
CO <sub>2</sub> – Measure <sup>3</sup>	Up to 2.5 % CO <sub>2</sub> Up to 5 % CO <sub>2</sub> Up to 10 % CO <sub>2</sub> Up to 20 % CO <sub>2</sub>	0.32 % CO <sub>2</sub> 0.35 % CO <sub>2</sub> 0.38 % CO <sub>2</sub> 0.52 % CO <sub>2</sub>	Geotech G100, ASTM E1292, ISO 8573-6, CEI EN 50270, CGA G-6
CO <sub>2</sub> – Measuring Equipment <sup>3</sup>	2.5 % CO <sub>2</sub> 5 % CO <sub>2</sub> 10 % CO <sub>2</sub> 20 % CO <sub>2</sub>	0.24 % CO <sub>2</sub> 0.26 % CO <sub>2</sub> 0.31 % CO <sub>2</sub> 0.46 % CO <sub>2</sub>	Reference gases

II. Dimensional

Parameter/Equipment	Range	CMC <sup>2,4</sup> (±)	Comments <sup>11</sup>
Calipers <sup>3</sup>	Up to 350 mm (>350 to 1000) mm	12 μm (480 μin) 20 μm (790 μin)	Caliper checker gage blocks: DIN 862; ISO 13385; JIS B 7507

Parameter/Equipment	Range	CMC <sup>2,4</sup> ( $\pm$ )	Comments <sup>11</sup>
Thickness & Feeler Gages <sup>3</sup>	Up to 0.01 mm (>0.01 to 1) mm (>1 to 2) mm (>2 to 3) mm (>3 to 10) mm (>10 to 20) mm (>20 to 30) mm (>30 to 40) mm (>40 to 50) mm	0.5 $\mu\text{m}$ (20 $\mu\text{in}$ ) 0.6 $\mu\text{m}$ (24 $\mu\text{in}$ ) 0.7 $\mu\text{m}$ (28 $\mu\text{in}$ ) 0.8 $\mu\text{m}$ (32 $\mu\text{in}$ ) 0.9 $\mu\text{m}$ (35 $\mu\text{in}$ ) 1 $\mu\text{m}$ (39 $\mu\text{in}$ ) 1.1 $\mu\text{m}$ (43 $\mu\text{in}$ ) 1.3 $\mu\text{m}$ (51 $\mu\text{in}$ ) 1.5 $\mu\text{m}$ (59 $\mu\text{in}$ )	Gage blocks; UMM: JIS B7524; DIN 2275
Micrometers <sup>3,14</sup>	Up to 50 mm Up to 100 mm Up to 200 mm Up to 300 mm Up to 450 mm Up to 575 mm Up to 1000 mm	0.0013 mm 0.0018 mm 0.0029 mm 0.0049 mm 0.0037 mm 0.0091 mm 0.0170 mm	Gage blocks: ISO 3611; DIN 863 Part 1-4; JIS B 7502; JIS B 7520
Flatness, Parallelism	Up to 0.05 mm	0.0004 mm	Optical flat, parallel
Length Indicators (Dial, Lever, Dial Gauge, Test, LVDT) <sup>3</sup>	Up to 100 mm	(1 + 0.5R) $\mu\text{m}$	Indicator calibrator; UMM: DIN 879; DIN 879-1; DIN 879-3; DIN 878; DIN 2270; JIS B7503; JIS B 7533; ISO 13102
Height Gages <sup>3</sup>	Up to 500 mm (>500 to 1000) mm	2.8 $\mu\text{m}$ (110 $\mu\text{in}$ ) 19 $\mu\text{m}$ (750 $\mu\text{in}$ )	Gage blocks, surface plate: JIS B7517; BS 1643; BS EN ISO 13225
Bore Gages	Up to 10 mm	1.0 $\mu\text{m}$ (39 $\mu\text{in}$ )	Gage blocks; ring gages; UMM: JIS B7515

Parameter/Equipment	Range	CMC <sup>2,4</sup> (±)	Comments <sup>11</sup>
Cylindrical & Taper Gages –  Pins & Plain Plugs <sup>10</sup>  Plain Rings <sup>10</sup>	Up to 100 mm (>100 to 300) mm (>300 to 550) mm  Up to 100 mm (>100 to 300) mm (>300 to 450) mm	1 µm (39 µin) 2 µm (79 µin) 2.8 µm (110 µin)  1 µm (39 µin) 2 µm (79 µin) 2.5 µm (98 µin)	UMM, gage blocks: ISO 594/1; ISO 80369-7; ASME B1.20.5; ISO 286; ISO 286-1; ISO 286-2 DIN 7162; DIN EN ISO 1938-1; DIN 7163; DIN 7164
Length Standards (Micrometer Settings, End Rods, Length Bars)	Up to 100 mm (>100 to 500) mm	1.5 µm (59 µin) 2.7 µm (110 µin)	UMM, gage blocks: BS 870; BS EN ISO 3611; JIS B 7502
Thread Wires	Up to 7 mm	0.6 µm (24 µin)	UMM, gage blocks: BS 5590; ASME B1.2
Bevel Protractors <sup>3</sup> , Clinometers, Bubble Levels	Up to 5° (>5 to 180)°	0.013 s 0.04 s	Angle blocks <sup>6</sup> , BS 1685; BS 958; DIN 877; JIS B 7510;
Measuring Rules <sup>3</sup>	Up to 0.2 m (>0.2 to 0.5) m (>0.5 to 1) m	0.5 mm (0.02 in) 0.9 mm (0.035 in) 1.2 mm (0.047 in)	Length standards: JIS B 7516
Measuring Tapes <sup>3</sup>	Up to 5 m (>5 to 10) m (>10 to 20) m (>20 to 30) m (>30 to 40) m (>40 to 50) m	1.8 mm (0.071 in) 2 mm (0.079 in) 2.3 mm (0.091 in) 2.9 mm (0.11 in) 3.1 mm (0.12 in) 3.6 mm (0.14 in)	Length standards: JIS B 7512; JIS B 7522; BS 4035; BS 4484-1

Parameter/Equipment	Range	CMC <sup>2,4</sup> (±)	Comments <sup>11</sup>
Cylindrical & Taper Thread Plug Gage –			
Pitch Diameter	Up to 100 mm (>100 to 300) mm (>300 to 550) mm	1.5 µm (59 µin) 2.1 µm (75 µin) 3.4 µm (140 µin)	Thread wires; UMM: ISO 7-1; ISO 7-2; ISO 965; ISO 1502; ISO 228; ISO 11363; ISO 15872; DIN 477; DIN 2999; DIN 103; DIN 40431; DIN 513; DIN 40430; DIN 158; DIN 158-1; DIN EN 10226; EN 10226; DIN 405; DIN EN 144-1; BS 93; BS 811; BS 84; BS 919; BS 21; BS EN 10226-1; DIN EN 10226-1; DIN EN 10226-2; DIN EN 10226-3; BS 3409; BS 4377; BS 1657; BS 1104; DIN 7756; MIL-T-21309; A-A-59158; FED STD H28; ASME B1.2; ASME B1.5; ASME B1.8; ASME B 1.9; ASME B1.12; ASME B1.15; ASME B1.20.1; ASME B1.20.3; ASME B1.20.5; ASME B1.20.7; ASME B1.13M; ASME B1.16M; ASME B1.21M; ASME B1.22M; ASME B18.29.1 ASME B 1.1; BS 1580; API Spec 5B; API Spec 7-2; AWWA C800-05; SAE MA 1696.
Major Diameter <sup>9</sup>	Up to 100 mm (>100 to 300) mm (>300 to 550) mm	1 µm (39 µin) 2 µm (79 µin) 2.8 µm (110 µin)	

Parameter/Equipment	Range	CMC <sup>2,4</sup> (±)	Comments <sup>11</sup>
Solid & Tapered Thread Ring Gage –			
Pitch Diameter	(0.5 to 100) mm (>100 to 300) mm (>300 to 450) mm	1.5 µm (59 µin) 3.9 µm (150 µin) 4.3 µm (170 µin)	Ball probe, micrometer Tri-O- Bor,UMM: ISO 7-1; ISO 7-2; ISO 228 ; ISO 965; ISO 1502; ISO 11363; ISO 15872; DIN 477; DIN 2999; DIN 103; DIN 40431; DIN 513; DIN 40430;DIN 158; DIN 158-1; DIN EN 10226; EN 10226; DIN 405; DIN EN 144-1; BS 93; BS 811;BS 84; BS 919; BS 21; BS EN 10226- 1; DIN EN 10226- 1;DIN EN 10226-2; DIN EN 10226-3; BS 3409; BS 4377; BS 1657; BS 1104; BS 1580-1; BS 1580-3; DIN 7756; MIL-T-21309; A-A-59158; FED STD H28; ASME B1.3; ASME B1.5; ASME B1.8; ASME B 1.9; ASME B1.12; ASME B1.15; ASME B1.20.1; ASME B1.20.3; ASME B1.20.5; ASME B1.20.7; ASME B1.13M; ASME B1.16M; ASME B1.21M; ASME B1.22M; ASME B1.1; API Spec 5B; API Spec 7-2; AWWA C800-05; SAE MA 1696.
Minor Diameter <sup>9</sup>	(6 to 50) mm (>50 to 100) mm	2.4 µm (94 µin) 2.9 µm (110 µin)	

Parameter/Equipment	Range	CMC <sup>2,4</sup> (±)	Comments <sup>11</sup>
Extensometers <sup>3</sup> –  Displacement	(0.01 to 500) mm	2.6 µm (100 µin)	Micrometers; indicators, gage blocks: ASTM E83; ASTM E2309; ASTM E2309/E2309M; ISO 5893; ASTM E8/E8M ISO 9513, ASTM D5311; ASTM D5311/D5311M
Length Measuring Instruments – UMMs, Bench Micrometers, Indicators, Calibrators, Caliper Checkers	Up to 1 mm (>1 to 20) mm (>20 to 50) mm (>50 to 100) mm (>100 to 200) mm (>200 to 300) mm	0.12 µm (4.7 µin) 0.18 µm (7.1 µin) 0.2 µm (7.9 µin) 0.24 µm (9.5 µin) 4 µm (160 µin) 5.6 µm (220 µin)	Gage blocks, LVDT
Line Standard Scales	Up to 1 mm (>1 to 10) mm (>10 to 50) mm (>50 to 200) mm	0.7 µm (28 µin) 1.3 µm (51 µin) 1.7 µm (67 µin) 2.5 µm (98 µin)	UMM: JIS B 7541
Measuring Projectors & Microscopes <sup>3</sup> –  Displacement  Angle	Up to 10 mm (>10 to 20) mm (>20 to 50) mm (>50 to 100) mm  (0 to 90)°	1.7 µm (67 µin) 2.3 µm (91 µin) 3.5 µm (140 µin) 6.4 µm (250 µin)  44" (0.000 213 rad)	Line standard scales: JIS B7184; JIS B7153; ASTM 1951; ASTM 112  Angle blocks
Surface (Granite) Plates - Measure  Flatness Only	Up to 2.5 m x 1.6 m	0.001 mm	ISO 8512-2, DIN 876, GGG-P-463cc, BS 817 to manufacturer or customer requirements

### III. Dimensional Testing/Calibration

Parameter/Equipment	Range	CMC <sup>2, 5</sup> (±)	Comments <sup>11</sup>
Linear Measurement (Single Axis) <sup>3, 7</sup>	Up to 0.2 m (>0.2 to 0.5) m (>0.5 to 1.0) m (>1.0 to 5.0) m (>5.0 to 10.0) m  Up to 50 mm	0.15 mm (0.0059 in) 0.7 mm (0.028 in) 0.9 mm (0.035 in) 2 mm (0.079 in) 3.3 mm (0.13 in)  3.0 µm (120 µin)	Length standards     Measuring projector
Inspection Fixtures – Length, Single Axis (Straight Edges, Knife Edges) <sup>12</sup>	Up to 500 mm	2.6 µm (79 µin)	LVDT; DIN 874; JIS B 7514
Inspection Fixtures – Length, Two Axis (V- Blocks, Bar Parallels, 1-2-3 Blocks, Squares, Sine Bars, Sine Plates, Angle Irons) <sup>12</sup>			BS 3731; BS 3064; JIS B 7523; JIS B 7526; JIS B 7539; JIS B 7540; JIS B 7514; DIN 875; DIN 875-1; DIN 874; DIN 2273; DIN 2274
Flatness	Up to 500 mm	5.6 µm (220 µin)	LVDT, granite plate
Angle	Up to 60° (5 to 60)° (>60 to 180)° (0.5 to 60)°	4" (0.000 019 rad) 0.6R 1.0R 36" (0.000 17 rad)	Sine bar, granite plate bevel protractor  Measuring projector
Parallelism	Up to 200 mm	3.0 µm (120 µin)	LVDT, granite plate
Perpendicularity	Up to 600 mm	2.8 µm (110 µin)	Square, granite plate, gage blocks



IV. Electrical – DC/Low Frequency

Parameter/Equipment	Range	CMC <sup>2, 16</sup> ( $\pm$ )	Comments <sup>11</sup>
DC Voltage – Measure <sup>3</sup>	0 mV 0.2 $\mu$ V to 200 mV 200 mV to 2 V (2 to 20) V (20 to 200) V (200 to 1000) V	0.4 $\mu$ V 9.5 $\mu$ V/V 10 $\mu$ V/V 7.9 $\mu$ V/V 13 $\mu$ V/V 13 $\mu$ V/V	Fluke 8588A, Keysight 3458A
DC Voltage – Generate <sup>3</sup>	0 mV 1 V 10 V 0.1 $\mu$ V to 220 mV 220 mV to 2.2 V (2.2 to 11) V (11 to 22) V (22 to 220) V (22 to 1100) V	0.54 $\mu$ V 6 $\mu$ V/V 3.9 $\mu$ V/V 9.2 $\mu$ V/V 7.0 $\mu$ V/V 7 $\mu$ V/V 4 $\mu$ V/V 9.2 $\mu$ V/V 11 $\mu$ V/V	Fluke 5522A, Fluke 5730A
DC High Voltage – Measure <sup>3</sup>	(1000 to 4000) V (4000 to 5000) V (5000 to 9000) V (9000 to 10 000) V (10 000 to 30 000) V	1.3 V 1.6 V 2.8 V 3.2 V 9.1 V	Vitrek 4700, HVL-35, HVP-35
DC Current – Measure <sup>3</sup>	0 $\mu$ A (0 to 20) $\mu$ A (20 to 200) $\mu$ A (0.2 to 1) mA (1 to 2) mA (2 to 20) mA (20 to 200) mA 200 mA to 2 A (2 to 30) A	0.42 nA 1 nA 2.6 nA 15 nA 25 nA 0.3 $\mu$ A 12 $\mu$ A 0.4 mA 27 mA	Fluke 8588A, Keysight 3458A
DC Current – Generate <sup>3</sup>	0 mA (10 to 220) $\mu$ A 220 $\mu$ A to 2.2 mA (2.2 to 22) mA (22 to 220) mA 220 mA to 2.2 A (2.2 to 3) A (3 to 10) A (10 to 20) A	0.62 nA 8.3 nA 0.072 $\mu$ A 0.72 $\mu$ A 9.2 $\mu$ A 170 $\mu$ A 1.2 mA 5.5 mA 21 mA	Fluke 5730A

Parameter/Equipment	Range	CMC <sup>2, 16</sup> ( $\pm$ )	Comments <sup>11</sup>
DC Current – Generate <sup>3</sup> (cont)	(20 to 150) A (150 to 500) A (500 to 1000) A	1 A 2.5 A 4.6 A	Fluke 5522A Fluke 5500A/Coil
Resistance – Measure <sup>3</sup>	0 $\Omega$ (0 to 2) $\Omega$ (2 to 20) $\Omega$ (20 to 200) $\Omega$ 200 $\Omega$ to 2 k $\Omega$ (2 to 20) k $\Omega$ (20 to 200) k $\Omega$ 200 k $\Omega$ to 2 M $\Omega$ (2 to 20) M $\Omega$ (20 to 100) M $\Omega$ 100 M $\Omega$ to 1 G $\Omega$	4 $\mu\Omega$ 25 $\mu\Omega/\Omega$ 25 $\mu\Omega/\Omega$ 18 $\mu\Omega/\Omega$ 18 $\mu\Omega/\Omega$ 19 $\mu\Omega/\Omega$ 19 $\mu\Omega/\Omega$ 29 $\mu\Omega/\Omega$ 73 $\mu\Omega/\Omega$ 580 $\mu\Omega/\Omega$ 11 m $\Omega/\Omega$	Fluke 8588A, Keysight 3458A, MetCal
Resistance – Generate <sup>3</sup>	0 $\Omega$ 1 $\Omega$ 1.9 $\Omega$ 10 $\Omega$ 19 $\Omega$ 100 $\Omega$ 190 $\Omega$ 1 k $\Omega$ 1.9 k $\Omega$ 10 k $\Omega$ 19 k $\Omega$ 100 k $\Omega$ 190 k $\Omega$ 1 M $\Omega$ 1.9 M $\Omega$ 10 M $\Omega$ 19 M $\Omega$ 100 M $\Omega$	40 $\mu\Omega$ 95 $\mu\Omega/\Omega$ 98 $\mu\Omega/\Omega$ 25 $\mu\Omega/\Omega$ 25 $\mu\Omega/\Omega$ 13 $\mu\Omega/\Omega$ 13 $\mu\Omega/\Omega$ 10 $\mu\Omega/\Omega$ 10 $\mu\Omega/\Omega$ 10 $\mu\Omega/\Omega$ 10 $\mu\Omega/\Omega$ 12 $\mu\Omega/\Omega$ 12 $\mu\Omega/\Omega$ 17 $\mu\Omega/\Omega$ 22 $\mu\Omega/\Omega$ 45 $\mu\Omega/\Omega$ 60 $\mu\Omega/\Omega$ 120 $\mu\Omega/\Omega$	Fluke 5730A



Parameter/Range	Frequency	CMC <sup>2, 16</sup> ( $\pm$ )	Comments <sup>11</sup>
AC Voltage – Measure <sup>3</sup> (cont)			
(1 to 10) V	10 Hz to 2 kHz (2 to 10) kHz (10 to 30) kHz (30 to 100) kHz (100 to 300) kHz 300 kHz to 1 MHz (1 to 2) MHz (2 to 4) MHz (4 to 8) MHz (8 to 10) MHz	0.01 % + 120 $\mu$ V 0.02 % + 190 $\mu$ V 0.04 % + 370 $\mu$ V 0.10 % + 950 $\mu$ V 0.39 % + 3.9 mV 1.4 % + 14 mV 2.3 % + 23 mV 6.4 % + 64 mV 10 % + 100 mV 17 % + 180 mV	Fluke 8588A, Keysight 3458A
(10 to 100) V	10 Hz to 2 kHz (2 to 10) kHz (10 to 30) kHz (30 to 100) kHz (100 to 300) kHz 300 kHz to 1 MHz	0.01 % + 1.2 mV 0.01 % + 1.2 mV 0.04 % + 3.7 mV 0.10 % + 9.5 mV 0.62 % + 39 mV 1.8 % + 140 mV	
(100 to 1000) V	40 Hz to 2 kHz (2 to 10) kHz (10 to 30) kHz (30 to 100) kHz	0.02 % + 14 mV 0.02 % + 14 mV 0.04 % + 37 mV 0.10 % + 96 mV	
AC Voltage <sup>3</sup> – Generate <sup>3</sup>			
(2.2 to 22) mV	(10 to 20) Hz (20 to 40) Hz (40 to 20) kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz 500 kHz to 1 MHz	0.02 % + 0.8 $\mu$ V 0.01 % + 0.7 $\mu$ V 0.01 % + 0.7 $\mu$ V 0.02 % + 0.9 $\mu$ V 0.05 % + 1.4 $\mu$ V 0.11 % + 2.4 $\mu$ V 0.14 % + 3.3 $\mu$ V 0.27 % + 7.4 $\mu$ V	Fluke 5522A, Fluke 5730A

Parameter/Range	Frequency	CMC <sup>2, 16</sup> ( $\pm$ )	Comments <sup>11</sup>
AC Voltage <sup>3</sup> – Generate <sup>3</sup> (cont)			
(22 to 220) mV	(10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz 500 kHz to 1 MHz	0.02 % + 5.3 $\mu$ V 0.01 % + 2.3 $\mu$ V 0.01 % + 2.1 $\mu$ V 0.01 % + 4.4 $\mu$ V 0.03 % + 11 $\mu$ V 0.06 % + 22 $\mu$ V 0.06 % + 29 $\mu$ V 0.27 % + 56 $\mu$ V	Fluke 5522A, Fluke 5730A
220 mV to 2.2 V	(10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz 500 kHz to 1 MHz	0.03 % + 49 $\mu$ V 0.01 % + 19 $\mu$ V 0.01 % + 19 $\mu$ V 0.01 % + 25 $\mu$ V 0.01 % + 64 $\mu$ V 0.04 % + 130 $\mu$ V 0.11 % + 280 $\mu$ V 0.18 % + 550 $\mu$ V	
(2.2 to 22) V	(10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz 500 kHz to 1 MHz	0.02 % + 0.5 mV 0.03 % + 0.5 mV 0.01 % + 0.1 mV 0.004 % + 0.1 mV 0.01 % + 0.2 mV 0.01 % + 0.8 mV 0.02 % + 2.2 mV 0.09 % + 3.8 mV	
(22 to 220) V	(10 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz	0.02 % + 5.2 mV 0.01 % + 2.0 mV 0.01 % + 1.5 mV 0.01 % + 1.9 mV	
(220 to 1100) V	50 Hz to 1 kHz	0.01 % + 19 mV	

Parameter/Range	Frequency	CMC <sup>2, 16</sup> ( $\pm$ )	Comments <sup>11</sup>
AC High Voltage – Measure  (1 to 5) kV (5 to 10) kV (10 to 30) kV	50/60 Hz	5.3 V 10 V 30 V	Vitretek 4700, HVL-35
AC Current – Measure <sup>3</sup>  (10 to 100) $\mu$ A  100 $\mu$ A to 1 mA  (1 to 10) mA  (10 to 100) mA  100 mA to 1 A  (1 to 30) A	10 Hz to 2 kHz (2 to 10) kHz  10 Hz to 2 kHz (2 to 10) kHz (10 to 30) kHz  10 Hz to 2 kHz (2 to 10) kHz (10 to 30) kHz  10 Hz to 2 kHz (2 to 10) kHz (10 to 30) kHz  1 Hz to 2 kHz (2 to 10) kHz	0.01 % + 0.033 $\mu$ A 0.01 % + 0.033 $\mu$ A  0.04 % + 0.042 $\mu$ A 0.04 % + 0.078 $\mu$ A 0.07 % + 0.10 $\mu$ A  0.04 % + 0.4 $\mu$ A 0.04 % + 0.8 $\mu$ A 0.07 % + 1.0 $\mu$ A  0.04 % + 4.1 $\mu$ A 0.08 % + 7.7 $\mu$ A 0.07 % + 9.9 $\mu$ A  0.04 % + 0.04 mA 0.08 % + 0.08 mA 0.10 % + 0.1 mA  0.26 % + 0.5 $\mu$ A 0.26 % + 0.8 $\mu$ A	Fluke 8588A, Keysight 3458A
AC Current – Generate <sup>3</sup>  (0.1 to 220) $\mu$ A  200 $\mu$ A to 2.2 mA	(1 to 100) Hz (100 to 500) Hz 500 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz  (1 to 100) Hz (1 to 5) kHz 5 kHz to 10) kHz	0.011 $\mu$ A 0.088 $\mu$ A 0.030 $\mu$ A 0.030 $\mu$ A 0.073 $\mu$ A  0.075 mA 0.03 mA 0.073 mA	Fluke 5730A

Parameter/Range	Frequency	CMC <sup>2, 16</sup> ( $\pm$ )	Comments <sup>11</sup>
AC Current – Generate <sup>3</sup> (cont)			
(2.2 to 22) mA	(1 to 100) Hz (1 to 5) kHz (5 to 10) kHz	0.0006 mA 0.0002 mA 0.0005 mA	Fluke 5730A
(22 to 220) mA	(1 to 100) Hz (1 to 5) kHz (5 to 10) kHz	0.005 mA 0.002 mA 0.005 mA	
220 mA to 2.2 A	(1 to 100) Hz (1 to 5) kHz (5 to 10) kHz	0.06 A 0.02 A 0.05 A	
(2.2 to 11) A	1 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz	0.04 A 0.001 A 0.01 A	
(11 to 20.5) A	(45 to 100) Hz 100 Hz to 1 kHz (1 to 5) kHz	0.02 A 0.01 A 0.01 A	
(20.5 to 220) A	(45 to 65) Hz	0.01 A	
(220 to 1000) A	(45 to 65) Hz	0.92 A	Fluke 5522A, Fluke 5500A/coil, MetCal

Parameter/Range	Frequency	CMC <sup>2, 16</sup> (±)	Comments <sup>11</sup>
Capacitance, Measure			Keysight E4980A LCR
10 pF	100 kHz to 1 MHz (1 to 2) MHz	0.3 % 1 %	
100 pF	(1 to 2) MHz	0.3 %	
1000	20 Hz to 1 kHz 1 kHz to 1 MHz (1 to 2) MHz	3 % 0.3 % 1 %	
0.1 μF	120 Hz to 100 kHz	0.3 %	
10 μF	20 Hz to 10 kHz (10 to 100) kHz	0.3 % 7 %	

Parameter/Equipment	Range	CMC <sup>2, 16</sup> (±)	Comments <sup>11</sup>
Capacitance, Measuring Instruments	(220 to 400) pF (0.4 to 3.3) nF (3.3 to 11) nF (11 to 110) nF (110 to 330) nF (0.33 to 1.1) μF (1.1 to 3.3) μF (3.3 to 11) μF (11 to 33) μF (33 to 110) μF (110 to 330) μF (330 to 1100) μF (1.1 to 3.3) mF (3.3 to 11) mF (11 to 33) mF (33 to 110) mF	0.5 % + 12 pF 0.5 % + 12 pF 0.27 % + 0.02 nF 0.27 % + 0.13 nF 0.29 % + 0.59 nF 0.12 % + 0.002 μF 0.25 % + 0.006 μF 0.25 % + 0.019 μF 0.39 % + 0.077 μF 0.45 % + 0.26 μF 0.45 % + 0.80 μF 0.45 % + 2.5 μF 0.45 % + 0.008 mF 1.1 % + 0.025 mF 0.76 % + 0.11 mF 1.2 % + 0.48 mF	Fluke 5522A



Parameter/Equipment	Range	CMC <sup>2, 16</sup> ( $\pm$ )	Comments <sup>11</sup>
Oscilloscope <sup>3</sup> –			
DC Voltage			Fluke 5520A/SC1100
50 $\Omega$	(0 to 6.6) V	0.06 V	
1 M $\Omega$	(0 to 130) V	0.05 % + 0.04 mV	
Flatness			
50 kHz Reference	50 kHz to 100 MHz	2.2 % + 5 mV	
	(100 to 300) MHz	2.4 % + 5 mV	
	(300 to 600) MHz	3.6 % + 5 mV	
	600 MHz to 1.1 GHz	2.7 % + 5 mV	
Squarewave			
10 Hz to 10 kHz			
50 $\Omega$	1 mV to 6.6 V <sub>p-p</sub>	0.017 V	
1 M $\Omega$	1 mV to 130 V <sub>p-p</sub>	0.1 % + 42 $\mu$ V	
Sinewave Flatness			
Relative to 50 kHz			
5 mV to 5.5 V	50 kHz to 100 MHz	3.3 % + 5.0 mV	
	(100 to 300) MHz	3.6 % + 5.0 mV	
	(300 to 600) MHz	5.0 % + 5.0 mV	
5 mV to 3.5 V	(0.6 to 1.1) GHz	3.6 % + 4.9 mV	
Rise Time – Generate	(200 to 300) ps	120 ps	
	1 kHz to 2 MHz		
	(200 to 350) ps	100 ps	
	2 MHz to 10 MHz		
Amplitude	5 mV to 2.5 V	0.3 mV + 10 %	
Time Marker – 50 $\Omega$	5 s to 50 ms	5 $\mu$ s	
	20 ms to 100 ns	50 ns	
	(50 to 20) ns	0.13 ps	
	10 ns	23 fs	
	(5 to 2) ns	13 fs	
Wave Generator			
50 $\Omega$	1.8 mV <sub>pk-pk</sub> to 2.5 V <sub>pk-pk</sub>	0.075 V <sub>pk-pk</sub>	
1 M $\Omega$	1.8 mV <sub>pk-pk</sub> to 55 V <sub>pk-pk</sub>	1.7 V <sub>pk-pk</sub>	

Parameter/Equipment	Range	CMC <sup>2, 16</sup> ( $\pm$ )	Comments <sup>11</sup>
Low Resistance (Earth Resistance) <sup>3</sup> – Generate	10 m $\Omega$ (100 to 500) m $\Omega$ (0.5 to 2) $\Omega$ (2 to 5) $\Omega$ (5 to 29.9) $\Omega$ (30 to 199.9) $\Omega$ (200 to 499) $\Omega$ 500 $\Omega$ to 1.999 k $\Omega$ (2 to 4.99) k $\Omega$ (5 to 10) k $\Omega$	0.51 m $\Omega$ 0.008 $\Omega$ + 0.4 % 0.010 $\Omega$ + 0.2 % 0.013 $\Omega$ + 0.24 % 0.017 $\Omega$ + 0.16 % 0.081 $\Omega$ + 0.15 % 0.66 $\Omega$ + 0.12 % 1 $\Omega$ + 0.15 % 7 $\Omega$ + 0.11 % 10 $\Omega$ + 0.15 %	Fluke 5322A
High Resistance (Insulation Resistance) <sup>3</sup> – Generate	(10 to 39.99) k $\Omega$ (40 to 99.99) k $\Omega$ (100 to 199.99) k $\Omega$ (200 to 999.99) k $\Omega$ (1 to 9.999) M $\Omega$ (10 to 999.9) M $\Omega$ (1 to 10) G $\Omega$ 100 G $\Omega$	47 $\Omega$ + 0.16 % 23 $\Omega$ + 0.22 % 11 $\Omega$ + 0.23 % 8.6 $\Omega$ + 0.23 % 1.8 $\Omega$ + 0.35 % 2.9 $\Omega$ + 0.6 % 1.1 M $\Omega$ + 1.2 % 3.5 G $\Omega$	Fluke 5322A, Metcal
High Resistance (Insulation Resistance) <sup>3</sup> – Source with R Multiplier	(0.35 to 99.99) G $\Omega$ (100 to 999.9) G $\Omega$ (1 to 10) T $\Omega$	7 M $\Omega$ + 1.3 % 2 G $\Omega$ + 2.4 % 31 G $\Omega$ + 3.5 %	Fluke 5322A
Ground Bond Resistance – Decade Source, Fixed Points <sup>3</sup>	1 m $\Omega$ 14 m $\Omega$ 39 m $\Omega$ 94 m $\Omega$ 340 m $\Omega$ 490 m $\Omega$ 960 m $\Omega$ 1.7 $\Omega$ 4.7 $\Omega$ 9 $\Omega$ 17 $\Omega$ 47 $\Omega$ 90 $\Omega$ 170 $\Omega$ 470 $\Omega$ 900 $\Omega$ 1.7 k $\Omega$	0.2 m $\Omega$ 0.7 m $\Omega$ 1.7 m $\Omega$ 1.8 m $\Omega$ 3.5 m $\Omega$ 3.5 m $\Omega$ 7.9 m $\Omega$ 0.008 $\Omega$ 0.021 $\Omega$ 0.036 $\Omega$ 0.039 $\Omega$ 0.24 $\Omega$ 0.40 $\Omega$ 0.80 $\Omega$ 2.0 $\Omega$ 4.0 $\Omega$ 7.8 $\Omega$	Fluke 5322A

Parameter/Equipment	Range	CMC <sup>2.16</sup> (±)	Comments <sup>11</sup>
Leakage Current - Generate <sup>3</sup>  Passive / Differential Mode	(0.1 to 30) mA	2.6 µA + 0.44 %	Fluke 5322A, Metcal
Residual Current Device –  Trip Current	(3 to 3000) mA	0.8 %	Fluke 5322A, Metcal
Trip Time Range	(10 to 5000) ms	0.29 ms + 0.029 %	
AC/DC Multimeters <sup>3</sup> – Voltage - DC	(4 to 10) V (10 to 100) V (100 to 1000) V (1000 to 5000) V	0.009 V + 0.17 % 0.10 V + 0.20 % 0.75 V + 0.20 % 6.8 V + 0.32 %	Fluke 5322A
AC/DC Multimeters <sup>3</sup> – Voltage - AC 50 Hz to 400 Hz	(4 to 10) V (10 to 100) V (100 to 1000) V (1000 to 5000) V	0.009 V + 0.17 % 0.10 V + 0.20 % 0.75 V + 0.20 % 7.7 V + 0.45 %	Fluke 5322A
AC/DC High Voltage Dividers –  DC	(5000 to 10 000) V	16 V + 0.27 %	Fluke 5322A
AC – (50 to 60) Hz	(5000 to 7000) V	32 V + 0.56 %	

Parameter/Equipment	Range	CMC <sup>2, 16</sup> ( $\pm$ )	Comments <sup>11</sup>
AC/DC Multimeter <sup>3</sup> – Current – AC 50 Hz to 400 Hz	(100 to 300) mA (0.3 to 3) A (3 to 20) A	0.24 mA + 0.12 % 2 mA + 0.12 % 23 mA + 0.24 %	Fluke 5322A
AC/DC Multimeter <sup>3</sup> – Current - DC	(100 to 300) mA (0.3 to 3) A (3 to 20) A	0.24 mA + 0.18 % 2 mA + 0.17 % 23 mA + 0.30 %	Fluke 5322A
AC Current <sup>3</sup> 20 Hz to 400 Hz	(100 to 300) mA (0.3 to 3) A (3 to 30) A	0.33 mA + 0.25 % 2 mA + 0.23 % 33 mA + 0.42 %	Fluke 5322A, Metcal
DC Current <sup>3</sup>	(100 to 300) mA (0.3 to 3) A (3 to 30) A	0.33 mA + 0.25 % 2 mA + 0.23 % 33 mA + 0.42 %	Fluke 5322A, Metcal
AC Current – Hipot Leakage Current Measurement <sup>3</sup> 20 Hz to 400 Hz	(30 to 300) $\mu$ A (0.3 to 3) mA (3 to 30) mA (30 to 300) mA	0.56 $\mu$ A + 0.42 % 4 $\mu$ A + 0.29 % 39 $\mu$ A + 0.29 % 0.39 mA + 0.29 %	Fluke 5322A, Metcal
DC Current – Hipot Leakage Current Measurement <sup>3</sup>	(30 to 300) $\mu$ A (0.3 to 3) mA (3 to 30) mA (30 to 300) mA	0.56 $\mu$ A + 0.42 % 4 $\mu$ A + 0.29 % 39 $\mu$ A + 0.29 % 0.39 mA + 0.29 %	Fluke 5322A, Metcal

Parameter/Equipment	Range	CMC <sup>2</sup> (±)	Comments <sup>11</sup>
Electrical Simulation of RTDs <sup>3</sup> –  Pt 50 Ω, Pt 100 Ω, Pt 200 Ω, Pt 500 Ω Pt 1000 Ω	(-190 to 830) °C	0.12 °C	Process calibrator: EURAMET/cg-11; AMS 2750
Electrical Simulation of Thermocouples <sup>3</sup> –			
Type B	(250 to 1800) °C	1.4 °C	Process calibrator: EURAMET/cg-11; AMS 2750
Type C	(250 to 900) °C (>900 to 2250) °C	0.31 °C 0.32 °C	
Type E	(-200 to 0) °C (>0 to 990) °C	0.20 °C 0.25 °C	
Type J	(-200 to 0) °C (>0 to 1190) °C	0.19 °C 0.20 °C	
Type K	(-200 to -100) °C (>-100 to 0) °C (>0 to 900) °C (>900 to 1360) °C	0.26 °C 0.20 °C 0.21 °C 0.23 °C	
Type N	(-200 to 0) °C (>0 to 1240) °C	0.21 °C 0.21 °C	
Type S	(-40 to 600) °C (>600 to 1730) °C	0.77 °C 0.34 °C	
Type T	(-200 to -180) °C (>-180 to 0) °C (>0 to 390) °C	0.41 °C 0.21 °C 0.20 °C	

V. Mechanical

Parameter/Equipment	Range	CMC <sup>2</sup> (±)	Comments <sup>11</sup>
Force <sup>3</sup> –			
Load Cell (Force Transducer)			ASTM E74; ISO 376
Compression & Tension	(0.001 to 1) kN (>1 to 10) kN	0.04 % of reading 0.05 % of reading	Dead weights
	(10 to 50) kN (>50 to 100) kN	0.057 % of reading 0.088 % of reading	Load cell standards
Compression	(100 to 500) kN (>500 to 5000) kN	0.073 % of reading 0.09 % of reading	Load cell standards
Testing Machines Force Push/Pull Gages Dynamometers			ASTM E4; ISO 7500-1; ISO 7500-2; BS EN 12390-4 (Israeli standard 26 part 4-1) <sup>13</sup>
Compression & Tension	Up to 50 kN (50 to 100) kN (100 to 200) kN (200 to 500) kN (500 to 1000) kN	0.052 % of reading 0.039 % of reading 0.063 % of reading 0.057 % of reading 0.033 % of reading	Dead weights
Compression	(500 to 1000) kN (1000 to 5000) kN	0.041 % of reading 0.039 % of reading	Load cell standards
Rate of Stress	(0.05 to 2) MPa/s	0.07 MPa/s	BS EN 12390-3; load cell, stop watch
Rate of Straining	(0.5 to 12) MPa/s (0.05 to 0.8) mm/mm/min	0.3 MPa/s 0.02 mm/mm/min	ASTM E2658; load cell, stop watch

Parameter/Equipment	Range	CMC <sup>2</sup> (±)	Comments <sup>11</sup>
Pressure Gages <sup>3</sup> – Pneumatic – Gage & Differential	(-1250 to 1250) kPa (-15 to 15) kPa (-100 to 100) kPa	0.8 Pa 3 Pa 0.14 kPa	OIML/R 101; Israeli standard 697; EA-10/17  Druck, LPE 9400 Druck, DPI 610 Druck, DPI 610
Absolute	(13 to 1250) Pa (0.04 to 200) kPa	0.73 Pa 0.53 kPa	Druck, LPE 940 Druck, DPI 104
Hydraulic & Pneumatic	(0 to 7) MPa (>7 to 70) MPa (>70 to 200) MPa	0.4 kPa 10 kPa 32 kPa	Druck, DPI 104 Druck, DPI 104 AEP Transducers LAB DMM
Pressure Testers, Pressure transducers, Pressure Indicators – Pneumatic –	(-100 to 100) kPa	2 Pa	Deadweight tester YANTRIKA, REW 401HAA/1
	(0 to 7) MPa	150 Pa	Deadweight tester YANTRIKA, REW 417HAA/1
Hydraulic	(0 to 7) MPa (>7 to 140) MPa	170 Pa 1 kPa	Deadweight tester YANTRIKA, REW 309HAO/

Parameter/Equipment	Range	CMC <sup>2</sup> (±)	Comments <sup>11</sup>
Durometers Calibration – Indenter – Extension & Shape			ASTM D 2240; ISO 868; DIN 53505; DIN ISO 7619-1; DIN ISO 48-4; ASTM D1415
Diameter	Diameter of the base of the cone 0.79 mm (A, C)	4 µm (160 µin)	Optical inspection under magnification
Radius	Tip radius R 0.1 mm (B, D), R 1.19 mm (O, DO)	3 µm (120 µin) 10 µm (390 µin)	
Angle	Cone angle 35° (A, C), 30° (B, D)	51" (0.00025 rad)	
Extension	2.5 mm (A, B, C, D, O, DO)	8 µm (320 µin)	Load cell standards; dead weights
Spring Calibration Force	(0.8 to 8.05) N - A, B, E, O (4.4 to 44.45) N - C, D, DO	0.04 N 0.4 N	
Scales & Balances <sup>3</sup> (Includes Analytical Balances)	Up to 20 mg (>20 to 100) mg (>100 to 1000) mg (>1 to 10) g (>10 to 20) g (>20 to 100) g (>100 to 200) g (>200 to 500) g (>500 to 1000) g (>1 to 10) kg (>10 to 200) kg (>200 to 1000) kg (1000 to 2400) kg	0.002 mg 0.003 mg 0.004 mg 0.009 mg 0.014 mg 0.092 mg 0.169 mg 0.8 mg 0.9 mg 0.08 g 1.3 g 15 g 23 g	Mass standards: Class E1, E <sub>2</sub> , F1, F2, M <sub>1</sub> , M <sub>2</sub> , M <sub>3</sub> , OIML R76-1, OIML R 111-1, EURAMET/cg-18, USP 41



Parameter/Equipment	Range	CMC <sup>2</sup> (±)	Comments <sup>11</sup>
Mass Pieces	1 mg & 2 mg 5 mg 10 mg 20 mg 50 mg & 100 mg 200 mg 500 mg 1 g 2 g 5 g 10 g 20 g 50 g 100 g 200 g 500 g, 1 kg, 10 kg, 20 kg 50 kg	0.001 mg 0.002 mg 0.004 mg 0.007 mg 0.009 mg 0.011 mg 0.013 mg 0.000 04 g 0.000 06 g 0.0001 g 0.0003 g 0.0005 g 0.001 g 0.003 g 0.005 g 0.014 g 0.11 g	OIML R101 OIML R 111-1 1 mg to 500 mg Grade E2. 1 g to 20 Grade F1 Accuracy grades: M <sub>1</sub> , M <sub>2</sub> , M <sub>3</sub>
Custom Weights/Fixtures <sup>3, 8</sup> —			
Mass	From (10 to 100) g (>100 to 1000) g (>1 to 10) kg (>10 to 30) kg	0.092 mg 0.9 mg 0.08 g 1.3 g	Precision scales <sup>6</sup> OIML R 111-1
Volume	Up to 5 ml (>5 to 20) ml (>20 to 150) ml (>150 to 200) ml (>200 to 500) ml (>500 to 1000) ml (>1000 to 5000) ml (>5000 to 10 000) ml (>10 000 to 15 000) ml (>15 000 to 20 000) ml (>20 000 to 50 000) ml	0.001 ml 0.002 ml 0.003 ml 0.004 ml 0.10 ml 0.11 ml 0.11 ml 0.20 ml 0.21 ml 0.22 ml 3.1 ml	Derived value ASTM C 231

Parameter/Equipment	Range	CMC <sup>2</sup> (±)	Comments <sup>11</sup>
<p>Torque –</p> <p>Torque Wrenches &amp; Torque Drivers<sup>3</sup></p> <p>Torque Calibrators</p>	<p>(0 to 0.25) N·m (0.25 to 0.7) N·m (0.7 to 2.5) N·m (2.5 to 25) N·m (25 to 250) N·m (150 to 1500) N·m</p> <p>Up to 2.8 N·m (&gt;2.8 to 28) N·m (&gt;28 to 135) N·m (&gt;135 to 500) N·m</p>	<p>0.066 N·m 0.068 N·m 0.11 N·m 0.009 N·m 0.13 N·m 0.48 N·m</p> <p>0.002 N·m 0.0039 N·m 0.023 N·m 0.074 N·m</p>	<p>Torque calibrators, ISO 6789; ISO 6789-1; ISO 6789-2</p> <p>Torque meter</p> <p>Dead weights &amp; arms; BS 7882</p>
Indirect Verification of Rockwell Hardness Testers <sup>3</sup>	<p>HRA: Low Medium High</p> <p>HRBW: Low Medium High</p> <p>HRC: Low Medium High</p> <p>HREW: Low Medium High</p> <p>HR15TW: Low Medium High</p>	<p>0.24 HRA 0.24 HRA 0.18 HRA</p> <p>0.58 HRBW 0.39 HRBW 0.40 HRBW</p> <p>0.29 HRC 0.24 HRC 0.40 HRC</p> <p>0.19 HREW 0.28 HREW 0.18 HREW</p> <p>0.28 HR15TW 0.25 HR15TW 0.31 HR15TW</p>	Hardness standards: ASTM E18; ISO 6508-2
Indirect Verification of Vickers Hardness Testers <sup>3</sup> (0.1, 0.5, 1 and 10) kg	<p>(≥100 to 240) HV (&gt;240 to ≤ 600) HV &gt;600 HV</p>	<p>3.3 HV 6.1 HV 8.1 HV</p>	Hardness standards: ASTM E384, ASTM E92; ISO 6507-2
Indirect Verification of Knoop Hardness Testers <sup>3</sup>	<p>(≥100 to 250) HK (&gt;250 to ≤ 650) HK &gt;650 HK</p>	<p>4.7 HK 5.6 HK 9.6 HK</p>	Hardness standards: ASTM E384; ISO 4545-2

Parameter/Equipment	Range	CMC <sup>2</sup> (±)	Comments <sup>11</sup>
Indirect Verification of Brinell Hardness Testers <sup>3</sup> , (10/3000, 10/1000, & 2.5/187.5)	<125 HBW (125 to 225) HBW >225 HBW	1.9 HBW 2.9 HBW 4.4 HBW	Hardness standards: ASTM E10; ISO 6506-2
Volume – Fixed Points (Volumetric Apparatus, Pipettes)	1 µl 2 µl 5 µl 10 µl 20 µl 50 µl 100 µl 200 µl 500 µl 1 ml 2 ml 5 ml 10 ml 20 ml 50 ml 100 ml	0.016 µl 0.016 µl 0.016 µl 0.016 µl 0.016 µl 0.017 µl 0.017 µl 0.017 µl 0.017 µl 0.018 µl 0.021 µl 0.40 µl 0.49 µl 0.66 µl 1.9 µl 2.4 µl	Gravimetric method with analytical balance: ISO 8655-1; ISO 8655-2; ISO 8655-3; ISO 8655-4; ISO 8655-5; ISO 8655-6
Sieves	Standard Sieve Designation (Customer Defined Parameters)	7 µm (280 µin)	Measuring projector; caliper; ASTM E11; ISO 3310-1; ISO 3310-2; ISO 3310-3; ISO 2395; ISO 565; ISO 9044-1999
Hammers <sup>3</sup> –  Weighing  Height of Free Fall	Defined by Standard  Defined by Standard	0.0012 g  0.9 mm (0.035 in)	ASTM D 1557; ASTM D 698; ASTM D 2168; ASTM D 1883 ASTM C805/C805M (Israeli standard 26 part 7). EN 12504-2

Parameter/Equipment	Range	CMC <sup>2</sup> (±)	Comments <sup>11</sup>
Impact Testing Devices <sup>3</sup> (Direct Method Only) –			
Energy	(1 to 5.5) J (>5.5 to 150) J (>150 to 406) J	0.21 J 0.51 J 3.2 J	ASTM D 256; ASTM E 23; AS 1146.3; EN 10045; ISO 148; ISO 148-1; ISO 148-2; BS 131; BS 131-1; BS 131-5; BS 131-6; BS 131-7;
Velocity	(3 to 6) m/s	0.004 m/s	

## VI. Thermodynamics

Parameter/Equipment	Range	CMC <sup>2</sup> (±)	Comments <sup>11</sup>
Thermocouple Calibration –			
Type E	(190 to 0) °C (>0 to 960) °C	0.24 °C 0.24 °C	AMS 2750; ASTM E220
Type J	(-190 to 0) °C (>0 to 960) °C	0.18 °C 0.24 °C	
Type K	(-190 to 0) °C (>0 to 230) °C (>230 to 660) °C (>660 to 960) °C (>960 to 1250) °C	0.19 °C 0.18 °C 0.22 °C 0.28 °C 2.5 °C	
Type N	(-190 to 0) °C (>0 to 230) °C (>230 to 660) °C (>660 to 960) °C (>960 to 1250) °C	0.28 °C 0.28 °C 0.22 °C 0.22 °C 2.5 °C	
Type R	(-40 to 0) °C (>0 to 600) °C (>600 to 960) °C (>960 to 1250) °C	0.96 °C 0.43 °C 0.46 °C 2.6 °C	

Parameter/Equipment	Range	CMC <sup>2, 17</sup> (±)	Comments <sup>11</sup>
Thermocouple Calibration – (cont)			
Type S	(-40 to 0) °C (>0 to 600) °C (>600 to 960) °C (>960 to 1250) °C	0.65 °C 0.49 °C 0.51 °C 2.6 °C	AMS 2750; ASTM E220
Type T	(-190 to 0) °C (>0 to 230) °C (>230 to 420) °C	0.20 °C 0.25 °C 0.23 °C	
RTD Probes Calibration	(-190 to 0) °C (>0 to 150) °C (>150 to 230) °C (>230 to 660) °C (>660 to 960) °C	0.09 °C 0.09 °C 0.09 °C 0.09 °C 0.1 °C	AMS 2750; ASTM E644; ASTM E1137; ASTM E1137/E1137M
Temperature Measuring Equipment –			SPRT, RTD standards:
Liquid in Glass Thermometers	(-80 to 0) °C (>0 to 100) °C (>100 to 230) °C	0.12 °C 0.09 °C 0.09 °C	ASTM E1; ASTM E77; ISO 1770; ISO 1771
Mechanical & Electrical Indicators with Probe(s)	(-190 to 0) °C (>0 to 100) °C (>100 to 420) °C (>420 to 660) °C	0.09 °C 0.09 °C 0.09 °C 0.09 °C	AMS 2750
Temperature – Measure			PRTs & thermocouple reference standards
Liquid Baths	(-190 to -40) °C (>-40 to 0) °C (>0 to 150) °C	0.09 °C 0.09 °C 0.09 °C	
Uniformity Surveys <sup>3</sup> (Ovens, Furnaces, Autoclaves & Freezers)	(-190 to 0) °C (>0 to 100) °C (>100 to 230) °C (>230 to 420) °C (>420 to 660) °C (>660 to 960) °C (>960 to 1250) °C	0.39 °C 0.17 °C 0.30 °C 0.35 °C 0.44 °C 0.54 °C 2.7 °C	Measurement & uniformity surveys; AMS 2750; ISO 17665-1; ISO 17665-2; SI 1291 (Israeli standard) <sup>15</sup>

Parameter/Equipment	Range	CMC <sup>2, 17</sup> ( $\pm$ )	Comments <sup>11</sup>
Relative Humidity – Measuring Equipment	(10 to 20) % RH (>20 to 40) % RH (>40 to 70) % RH (>70 to 95) % RH	0.68 % RH 0.86 % RH 1.1 % RH 1.4 % RH	Humidity chamber
Measure <sup>3</sup>	(10 to 20) % RH (>20 to 65) % RH (>65 to 90) % RH	1.0 % RH 1.3 % RH 1.4 % RH	Rotronic humidity indicator
Dewpoint – Measuring Equipment	(-40 to 95) °C	0.056 °C	Chilled mirror ASTM D4230, ASTM E104, ASTM E546, ASTM E576, MIL-I-24144, MIL-M-24144
Measure <sup>3</sup>	(-40 to 180) °C	0.2 °C	

## VII. Time & Frequency

Parameter/Equipment	Range	CMC <sup>2, 4, 17</sup> ( $\pm$ )	Comments
Frequency – Sources	(0.037 Hz to 10 MHz)	$10^{-11}$ (24 h)	Fluke 910R Via GPS System Via Ref. Locked to 910R Keysight 53230A MetCal
	(10 MHz to 1.1 GHz)	$5 \times 10^{-9}$ (0.3 h)	
Frequency – Measure	(0.1 Hz to 100 MHz)	$4.8 \times 10^{-9}$ (0.3h)	Fluke 910R Fluke 5522A System locked to 910R Keysight 53230A
	(100 MHz to 1.1 GHz)	$4.8 \times 10^{-10}$ (0.3h)	
	(0.1 Hz to 1.1 GHz)	$1.4 \times 10^{-5}$ (0.3h)	
Stopwatches & Timers <sup>3</sup>	1 s to 24 hr	0.09 s	Stopwatch

Parameter/Equipment	Range	CMC <sup>2, 4, 17</sup> ( $\pm$ )	Comments
Rotational Speed – Measure <sup>3, 4</sup> –  Optical Rotational Speed (RPM)  Mechanical Rotational Speed (RPM)	(15 to 60) RPM (>60 to 3000) RPM (>3000 to 24 000) RPM (>24000 to 48 000) RPM (>48 000 to 90 000) RPM RPM  (1.5 to 30) RPM (30 to 60) RPM (>60 to 600) RPM (>600 to 1000) RPM (>1000 to 6000) RPM	0.18 RPM 0.34 RPM 4 RPM 30 RPM 54 RPM  0.17 RPM 0.18 RPM 0.24 RPM 0.63 RPM 2 RPM	Optical tachometer (mode photo) ASTM D4060  Mechanical tachometer (mode contact)
Speed – Measure <sup>3, 4</sup>  Surface Speed	(10 to 400) m/min	0.25 m/min	Mechanical tachometer (mode m/min)
Length Counter – Measure <sup>3</sup>	(2 to 1000) m	0.5 m	Mechanical tachometer; (mode m/min), mechanical stopwatch

<sup>1</sup> This laboratory offers commercial calibration, dimensional testing, and field calibration services.

<sup>2</sup> Calibration and Measurement Capability Uncertainty (CMC) is the smallest uncertainty of measurement that a laboratory can achieve within its scope of accreditation when performing more or less routine calibrations of nearly ideal measurement standards or nearly ideal measuring equipment. CMCs represent expanded uncertainties expressed at approximately the 95 % level of confidence, usually using a coverage factor of  $k = 2$ . The actual measurement uncertainty of a specific calibration performed by the laboratory may be greater than the CMC due to the behavior of the customer's device and to influences from the circumstances of the specific calibration.

<sup>3</sup> Field calibration service is available for this calibration. Please note the actual measurement uncertainties achievable on a customer's site can normally be expected to be larger than the CMC found on the A2LA Scope. Allowance must be made for aspects such as the environment at the place of calibration and for other possible adverse effects such as those caused by transportation of the calibration equipment. The usual allowance for the actual uncertainty introduced by the item being calibrated, (e.g. resolution) must also be considered and this, on its own, could result in the actual measurement uncertainty achievable on a customer's site being larger than the CMC.

- <sup>4</sup> In the statement of CMC,  $L$  is the numerical value of the nominal length of the device measured in meters. In the statement of best uncertainty,  $R$  is the numerical value of the resolution of the device measured in micrometers; LSVD represents the least significant valid displayed division of the device subject to calibration; RPM is revolution per minute, ORM is oscillation per minute.
- <sup>5</sup> In the statement of CMC,  $R$  is the numerical value of the resolution of the angle measuring devices measured in degrees or in minutes.
- <sup>6</sup> Calibrated by P.K. Labs
- <sup>7</sup> This laboratory meets R205 – *Specific Requirements: Calibration Laboratory Accreditation Program* for the types of dimensional tests listed above and is considered equivalent to that of a calibration.
- <sup>8</sup> Including weighing of distilled water (density 1 g/cm<sup>3</sup>) and conversion to the volume units.
- <sup>9</sup> Compliance according to the policy of the P.K.Labs
- <sup>10</sup> Compliance of the setting or limit gauges according to the policy of the P.K.Labs.
- <sup>11</sup> Calibration can be also performed to manufacturer or specific customer requirements.
- <sup>12</sup> This test is not equivalent to that of a calibration.
- <sup>13</sup> Calibration of the compression machines for testing of hardened concrete (Israeli standard 26 part 4-1-is the Hebrew version)
- <sup>14</sup> Calibration of micrometers "Tri-O-Bor"(internal micrometer with three-point contact) according to test instruction VDI/VDE/DGO 2618 as an expansion of DIN 863
- <sup>15</sup> Calibration of the vehicles for food transport in a controlled temperature (Israeli standard 1291 is the Hebrew version)
- <sup>16</sup> The stated measured values are determined using the indicated instrument (see Comments). This capability is suitable for the calibration of the devices intended to measure or generate the measured value in the ranges indicated. CMC's are expressed as either a specific value that covers the full range or as a percent or fraction of the reading plus a fixed floor specification
- <sup>17</sup> The type of instrument or material being calibrated is defined by the parameter. This indicates the laboratory is capable of calibrating instruments that measure or generate the values in the ranges indicated for the listed measurement parameter
- <sup>18</sup> This scope meets A2LA's *P112 Flexible Scope Policy*.